Test Equipment Solutions Datasheet

Test Equipment Solutions Ltd specialise in the second user sale, rental and distribution of quality test & measurement (T&M) equipment. We stock all major equipment types such as spectrum analyzers, signal generators, oscilloscopes, power meters, logic analysers etc from all the major suppliers such as Agilent, Tektronix, Anritsu and Rohde & Schwarz.

We are focused at the professional end of the marketplace, primarily working with customers for whom high performance, quality and service are key, whilst realising the cost savings that second user equipment offers. As such, we fully test & refurbish equipment in our in-house, traceable Lab. Items are supplied with manuals, accessories and typically a full no-quibble 1 year warranty. Our staff have extensive backgrounds in T&M, totalling over 150 years of combined experience, which enables us to deliver industry-leading service and support. We endeavour to be customer focused in every way right down to the detail, such as offering free delivery on sales, presenting flexible technical + commercial solutions and supplying a loan unit during warranty repair, if available.

As well as the headline benefit of cost saving, second user offers shorter lead times, higher reliability and multivendor solutions. Rental, of course, is ideal for shorter term needs and offers fast delivery, flexibility, try-before-you-buy, zero capital expenditure, lower risk and off balance sheet accounting. Both second user and rental improve the key business measure of Return On Capital Employed.

We are based at Aldermaston in the UK from where we supply test equipment worldwide. Our facility incorporates Sales, Support, Admin, Logistics and our own in-house Lab.

All products supplied by Test Equipment Solutions include:

- No-quibble parts & labour warranty (we provide transport for UK mainland addresses).
- Free loan equipment during warranty repair, if available.
- Full electrical, mechanical and safety refurbishment in our 40GHz in-house Lab.
- Certificate of Conformance (calibration available on request).
- Manuals and accessories required for normal operation.
- Free insured delivery to your UK mainland address (sales).
- Support from our team of seasoned Test & Measurement engineers.
- ISO9001 quality assurance.

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R6243/6244
DC Voltage Current Source/Monitor

Optimal for Evaluating Electronic Circuits (Parts) with Flexible Source and Measurement of DC Voltage and Current



R6243/6244 is a DC voltage and current source/monitor with wide ranges of generation and measurement.

R6243: Voltage = 0 to \pm 110 V, current = 0 to \pm 2 A

R6244: Voltage = 0 to \pm 20 V, current = 0 to \pm 10 A

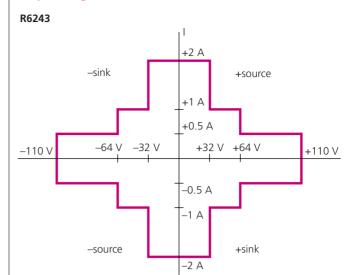
The R6243/6244 provide high accuracy with a setting resolution of 4 1/2 digits and a measuring resolution of 5 1/2 digits, a variety of sweep functions and a pulse measuring function for the minimum pulse width of 1 ms. The R6243/6244 can be used a power supply in many applications such as for test system, for evaluations of semiconductors and other electronic parts in R&D, etc.,

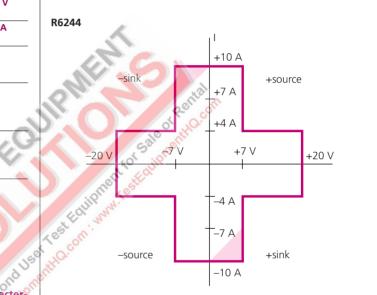
	R6243	R6244	
Maximum output current	±2 A at up to ±32 V ±1 A at up to ±64 V ±0.5 A at up to ±110 V	±10 A at up to ±7 V ±4 A at up to ±20 V	
Voltage source/measurement range	320 mV to 110 V	320 mV to 20 V	
Current source/measurement range	32 μA to 2 A	320 μA to 10 A	
Number of digits Source measurement	4 1/2 5 1/2		
Voltage source/measurement resolution Source measurement	: 10 μV 1 μV		
Current source/measurement resolution Source measurement	1 nA 100 pA	10 nA 1 nA	

- Voltage source and current measurement (VSIM)/ Current source and voltage measurement (ISVM)
- Voltage source and voltage measurement (VSVM)/ Current source and current measurement (ISIM)
- Sink enabled bipolar output
- Minimum pulse width: 1 ms
- Linear, logarithmic, and random sweep functions for characteristics tests
- Limiter (compliance), oscillation, overload, and overheat detection functions
- Synchronous operation function by combining two R6243/6244s or more
- GPIB for automatic measuring system



Output Range



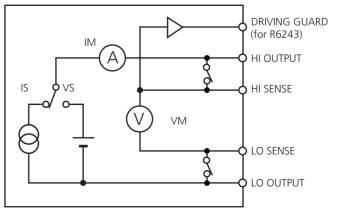


parts: The operating environmental temperature is 0 to 40°C

Source and Measurement Functions

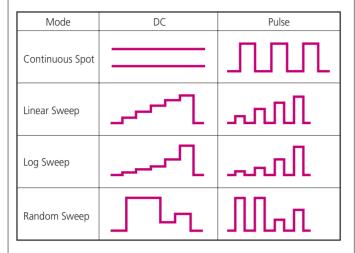
Voltage source/current source and voltage measurement/current measurement can be selected.

R6243/6244



Source Modes

The R6243/6244 has four source modes – DC, pulse, DC sweep, and pulse sweep. The sweep can be selected three types of mode such as linear, log, and random (arbitrary waveform generation by user programming).



The R6243/6244 can generate a pattern for a device test without exchanging data with an external controller. Further it can read out measurement results from the memory after the test.

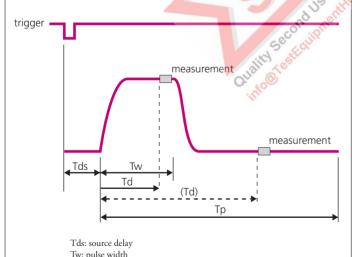
Note: The pulses across polarities cannot be generated.

Source/Measurement Timing

Td: measure delay Tp: period

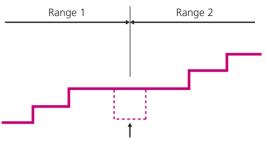
In pulse and sweep modes, the source and measurement timings are synchronous and the measurement is permitted after a specified time from trigger.

Setting the measure delay (Td) permits a measurement after a specified time from the end of the pulse such as stress tests.



Range Switching without Discontinuity

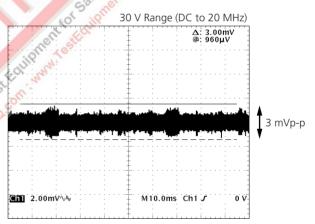
The voltage and current source ranges can be changed without lowering the output to zero from the level before switching. This allows no discontinuity at the output and reduces adverse effects on devices with hysteresis or high dielectric constant.



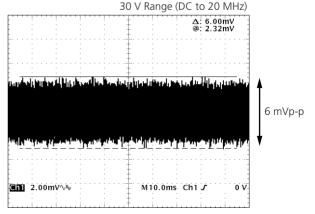
Range Switching without Lowering the Output to Zero

Low Noise

The basic requirements for power supply performance are accuracy of the voltage/current source and measuring against the noise added on the output voltage/current. The R6243/6244 has a minimum-noise design effective for the case susceptible to power noise and input signals of DC amplifier. The R6243/6244 is the perfect power supply for a linear IC, optical device, or mobile communication amplifier.



Output noise of R6243/6244

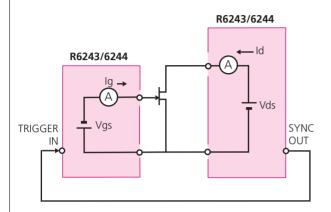


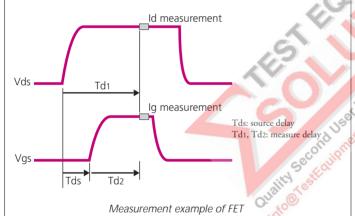
Output noise of our conventional models

For a transistor, FET characteristics test

In a transistor or FET characteristics test, two units of R6243/6244 can be used for simultaneous measurement. The R6243/6244 controls the generation timings of the drain and gate voltage to protect a device from stress. It can measure Id and Ig simultaneously.

- Linear, log, and random sweep functions
- Pulse measurement (minimum pulse width: 1 ms)
- Measure delay function for measurement timing control
- Source delay function for generation timing control



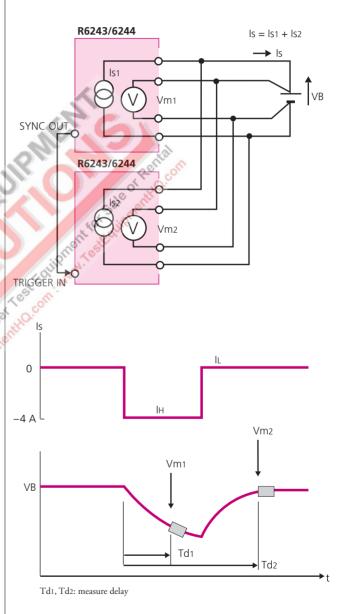


Measurement example of FET

For a battery charge and discharge test

The R6243/6244 is available for a battery charge and discharge test at constant current (CC) or constant voltage (CV) by DC or pulse applications. For a pulse charge and discharge test, measurement is necessary while and after the pulse application. Two units of R6243/6244 can be used in parallel operation for measurement at the above two points and to increase the current capacity up to 20 A.

- Source sink current up to ±20 A (7 V)
- 20 A (R6244) and 4 A (R6243) by two units in parallel operation
- Measurement at pulse HI/LO point
- Selection of voltage or current measurement



Example of Battery Charge and Discharge Test

For a temperature dependency test of diode Vf

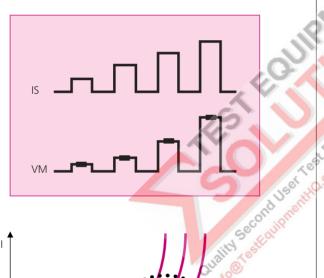
In a characteristics test on a power diode, applying a pulse current is effective for avoiding the influence of self-heating.

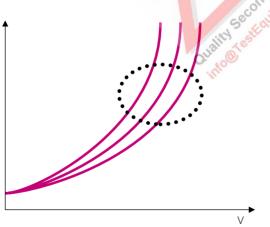
The current pulse sweep function and the pulse-synchronous

The current pulse sweep function and the pulse-synchronous voltage measurement ensure accurate Vf characteristics test at a large current.

Current pulse sweep ISVM







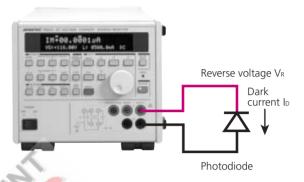
Temperature Dependence of VF by Pulse Width Variation

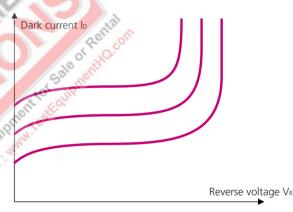
For a dark current characteristics test of photodiode

The following functions of R6243 are effective for photodiode characteristics test:

- Dark current reverse voltage characteristics test function using the 100 pA resolution
- Breakdown voltage measurement by ±110 V source and comparator

DC voltage sweep VSIM



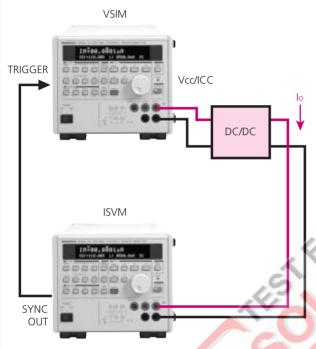


Temperature Dependence of the Dark Current – Reverse Voltage Characteristic

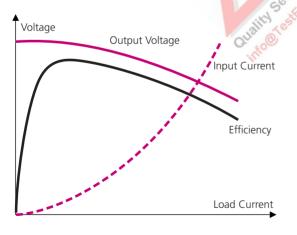
For a DC/DC converter characteristics test

The following functions are effective for DC/DC converter characteristics test:

- Simultaneous measurement of input current and output voltage/current by using two units of R6243/6244
- Electronic load operates even at 0 V (General electronic loads do not operate at 0.8 V or less)
- Large output current up to 10 A (7 V) (R6244)



Synchronous Measurement of Input Current and Output Voltage



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Specifications

All accuracies are guaranteed for one year when used at temparatures of $23\pm5^{\circ}$ C, relative humidity 85% or less.

R6243

Voltage Source/Measurement Range

Range	Source Range	Setting Resolution	Measurement Range	Measurement Resolution
320 mV	0 to ±320.00 mV	10 μV	0 to ±320.000 mV	1 μV
3.2 V	0 to ±3.2000 V	100 μV	0 to ±3.20000 V	10 μV
32 V	0 to ±32.000 V	1 mV	0 to ±32.0000 V	100 μV
110 V	0 to ±110.00 V	10 mV	0 to ±110.000 V	1 mV

Current Source/Measurement Range

Range	Source Range	Setting Resolution	Measurement Range	Measurement Resolution
32 µA	0 to ±32.000 μA	1 nA	0 to ±32.0000 μA	100 pA
320 µA	0 to ±320.00 μA	10 nA	0 to ±320.000 μA	1 nA
3.2 mA	0 to ±3.2000 mA	100 nA	0 to ±3.20000 mA	10 nA
32 mA	0 to ±32.000 mA	1 μΑ	0 to ±32.0000 mA	100 nA
320 mA	0 to ±320.00 mA	10 μΑ	0 to ±320.000 mA	1 μΑ
2 A	0 to ±2000.0 mA	100 μΑ	0 to ±2000.00 mA	10 μA

At the Integration Times of 500 μs and 1 ms, the measurement resolution is as follows:

Integration time	500 μs	1 ms	
Measurement Resolution (digits)	5	3	

Voltage Limiter (Compliance) Range

Range	Maximum Setting	Minimum Setting	Setting Resolution
320 mV	320.00 mV	3 mV	10 μV
3.2 V	3.2000 V	30 mV	100 μV
32 V	32.000 V	300 mV	1 mV
110 V	110.00 V	3 V	10 mV

Current Limiter (Compliance) Range

Range	Maximum Setting	Minimum Setting	Setting Resolution
32 µA	32.000 µA	300 nA	1 nA
320 µA	320.00 µA	3 μΑ	10 nA
3.2 mA	3.2000 mA	30 μΑ	100 nA
32 mA	32.000 mA	300 μA	1 μ A
320 mA	320.00 mA	3 mA	10 μA
2 A	2000.0 mA	30 mA	100 μΑ

Total Accuracy: Including calibration accuracy, 1-day stability, temperature coefficient, and linearity

1-day Stability: For power source, under a constant load Temperature coefficient: At Temparature of 0 to 50°C Voltage Source/Voltage Limiter

D	Total Accuracy	1-day Stability	Temperature coefficient
Range	±(% of setting + V)		±(ppm of setting + V)/°C
3.2 V	0.03 + 200 μV 0.03 + 600 μV 0.03 + 6 mV 0.03 + 30 mV	0.01 + 100 µV 0.01 + 300 µV 0.01 + 3 mV 0.01 + 20 mV	15 + 20 μV 15 + 50 μV 15 + 500 μV 15 + 2 mV

Current Source/Current Limiter

D	Total Accuracy	1-day Stability	Temperature coefficient
Range	±(% of setting +	±(ppm of setting + A + A x Vo/1 V)/°C	
32 µA	0.03 + 10 nA + 300 pA	0.015 + 4 nA + 200 pA	25 + 1 nA + 10 PA
320 μA	0.03 + 100 nA + 3 nA	0.015 + 40 nA + 2 nA	25 + 10 nA + 100 PA
3.2 mA	0.03 + 1 µA + 30 nA	0.01 + 400 nA + 20 nA	20 + 100 nA + 1 nA
32 mA	0.03 + 10 µA + 300 nA	0.01 + 4 µA + 200 nA	20 + 1 μA + 10 nA
320 mA	0.05 + 100 μA + 3 μA	0.015 + 40 μA + 2 μA	20 + 10 μA + 100 nA
2 A	0.06 + 1 mA + 30 µA	0.03 + 400 μA + 20 μA	20 + 100 μA + 1 μA

Vo; Compliance Volage (0 to ±110 V)

Voltage Measurement

Dange	Total Accuracy	1-day Stability	Temperature coefficient
Range	±(% of rea	±(ppm of reading + V)/°C	
320 mV	0.03 + 100 μV	0.008 + 50 μV	15 + 8 μV
3.2 V	0.03 + 150 μV	0.008 + 100 μV	15 + 10 μV
32 V	0.03 + 1 mV	0.008 + 500 µV	15 + 50 µV
110 V	0.03 + 8 mV	0.008 + 3 mV	15 + 500 μV

Current Measurement

Daniel	Total Accuracy	1-day Stability	Temperature coefficient
Range ±(% of reading		+ A + A x Vo/1 V)	±(ppm of reading +A+ A x Vo/1 V)/°C
32 µA	0.03 + 8 nA + 300 pA	0.015 + 3.5 nA + 200 pA	25 + 600 pA + 10 PA
320 µA	0.03 + 80 nA + 3 nA	0.015 + 35 nA + 2 nA	25 + 6 nA + 100 PA
3.2 mA	0.03 + 800 nA + 30 nA	0.01 + 350 nA + 20 nA	20 + 60 nA + 1 nA
32 mA	0.03 + 8 µA + 300 nA	0.01 + 3.5 μA + 200 nA	20 + 600 nA + 10 nA
320 mA	0.05 + 80 μA + 3 μA	0.015 + 35 μA + 2 μA	20 + 6 μA + 100 nA
2 A . "	0.06 + 800 μA + 30 μA	0.03 + 350 μA + 20 μA	20 + 60 μA + 1 μA

Vo; Compliance Volage (0 to ±110 V)(Auto Zero: ON, Integration Time: 1 to 100 PLC)

Integration time: For 10 ms to 500 µs measurement accuracy and 1-day stability, the following error is added.

	Pango	In	Unit: digits	
	Range	10 ms	1 ms	500 μs
Voltage Measurement	320 mV 3.2 V to 20 V	30 6	50 12	60 15
Current Measurement	32 μA 320 μA 3.2 mA to 2 A	30 15 10	50 25 15	70 30 20

Source Linearity: ±0.01% of range

Maximum Output Current: ± 2 A at up to 32 V, ± 1 A at up to 64 V,

±0.5 A at up to 110 V

Maximum Compliance Volage: ± 110 V at up to 0.5 A, ± 64 V at up to 1 A, ± 32 V at up to 2 A

R6244

Voltage Source/Measurement Range

Range	Source Range	Setting Resolution	Measurement Range	Measurement Resolution
320 mV	0 to ±320.00 mV	10 μV	0 to ±320.000 mV	1 μV
3.2 V	0 to ±3.2000 V	100 μV	0 to ±3.20000 V	10 μV
20 V	0 to ±20.000 V	1 mV	0 to ±20.0000 V	100 μV

Current Source/Measurement Range

Range	Source Range	Setting Resolution	Measurement Range	Measurement Resolution
320 µA	0 to ±320.00 μA	10 nA	0 to ±320.000 μA	1 nA
3.2 mA	0 to ±3.2000 mA	100 nA	0 to ±3.20000 mA	10 nA
32 mA	0 to ±32.000 mA	1 μΑ	0 to ±32.0000 mA	100 nA
320 mA	0 to ±320.00 mA	10 μΑ	0 to ±320.000 mA	1 μΑ
3.2 A	0 to ±3200.0 mA	100 μΑ	0 to ±3200.00 mA	10 μΑ
10 A	0 to ±10.000 A	1 mÅ	0 to ±10.0000 A	100 μA

At the Integration Times of 500 µs and 1 ms, the measurement resolution is as follows

Integration time	500 μs	1 ms
Measurement Resolution (digits)	5	3

Voltage Limiter (Compliance) Range

Range	Maximum Setting	Minimum Setting	Setting Resolution
320 mV	320.00 mV	3 mV	10 μV
3.2 V	3.2000 V	30 mV	100 μV
20 V	20.000 V	300 mV	1 mV

Current Limiter (Compliance) Range

Range	Maximum Setting	Minimum Setting	Setting Resolution
320 µA	320.00 μA	3 μΑ	10 nA
3.2 mA	3.2000 mA	30 μA	100 nA
32 mA	32.000 mA	300 μA	1 μΑ
320 mA	320.00 mA	3 mA	10 μA
3.2 A	3200.0 mA	30 mA	100 μΑ
10 A	10.000 A	300 mA	1 mA

Total Accuracy: Including calibration accuracy, 1-day stability, temperature coefficient, and linearity

1-day Stability: For power source, under a constant load Temperature coefficient: At Temparature of 0 to 50°C Voltage Source/Voltage Limiter

Danna	Total Accuracy	1-day Stability	Temperature coefficient
Range	±(% of setting + V)		±(ppm of setting + V)/°C
320 mV	0.03 + 300 μV	0.01 + 150 μV	15 + 30 μV
3.2 V	0.03 + 600 µV	0.01 + 300 μV	15 + 50 μV
20 V	0.03 + 6 mV	0.01 + 3 mV	15 + 500 μV

Current Source/Current Limiter

D	Total Accuracy	1-day Stability	Temperature coefficient		
Range	±(% of setting + A + A x Vo/1 V)		±(% of setting + A + A x Vo/1 V) ±(ppm of setting + A + A		±(ppm of setting + A + A x Vo/1 V)/°C
320 µA	0.03 + 100 nA + 3 nA	0.015 + 42 nA + 2 nA	25 + 10 nA + 100 PA		
3.2 mA	0.03 + 1 µA + 30 nA	0.01 + 420 nA + 20 nA	20 + 100 nA + 1 nA		
32 mA	0.03 + 10 µA + 300 nA	0.01 + 4.2 μA + 200 nA	20 + 1 μA + 10 nA		
320 mA	0.05 + 100 μA + 3 μA	0.015 + 42 μA + 2 μA	20 + 10 μA + 100 nA		
3.2 A	0.06 + 1 mA + 30 µA	0.03 + 420 μA + 20 μA	20 + 100 μA + 1 μA		
10 A	0.1 + 10 mA + 300 μA	0.08 + 4.2 mA + 200 μA	90 + 1 mA + 10 μA		

Vo; Compliance Volage (0 to ±20 V)

Voltage Measurement

Panga	Total Accuracy	1-day Stability	Temperature coefficient
Range ±(% of reading		ading + V)	±(ppm of reading + V)/°C
320 mV	0. 0 3 + 200 μV	0.008 + 100 μV	15 + 20 μV
3.2 V	0.03 + 200 μV	0.008 + 100 μV	15 + 20 μV
20 V 💉	0.03 + 1 mV	0.008 + 500 μV	15 + 50 μV

Current Measurement

	Total Accuracy	1-day Stability	Temperature coefficient
Range	±(% of reading	+ A + A x Vo/1 V)	±(ppm of reading +A+ A x Vo/1 V)/°C
320 µA	0.03 + 80 nA + 3 nA	0.015 + 40 nA + 2 nA	25 + 8 nA + 100 PA
3.2 mA	0.03 + 800 nA + 30 nA	0.01 + 400 nA + 20 nA	20 + 80 nA + 1 nA
32 mA	$0.03 + 8 \mu A + 300 nA$	0.01 + 4 µA + 200 nA	20 + 800 nA + 10 nA
320 mA	0.05 + 80 μA + 3 μA	0.015 + 40 μA + 2 μA	20 + 8 μA + 100 nA
3.2 A	0.06 + 800 μA + 30 μA	0.03 + 400 μA + 20 μA	20 + 80 μA + 1 μA
10 A	0.1 + 8 mA + 300 μA	0.08 + 4 mA + 200 μA	90 + 800 μA + 10 μA

Vo; Compliance Volage (0 to ±20 V)(Auto Zero: ON, Integration Time: 1 to 100 PLC)

Integration time: For 10 ms to 500 µs measurement accuracy and 1-day stability, the following error is added.

NETT THE PARTY OF	Range	Integration time Unit: digits		
	Range	10 ms	1 ms	500 µs
Voltage	320 mV	30	50	60
Measurement	3.2 V to 20 V	6	12	15
Current	320 μA	15	25	30
Measurement	3.2 mA to 10 A	10	15	20

Source Linearity: ±0.012% of range

At the range of 320 mA, 3.2 A, 10 A, the following error is added.

	Range	±(% of setting)
	320 mA	0.01
Current Source	3.2 A	0.02
	10 A	0.07

Maximum Output Current: ±10 A at up to 7 V, ±4 A at up to 20 V Maximum Compliance Voltage: ±20 V at up to 4 A, ±7 V at up to 10 A

R6243/6244 Common Specifications

R6243/6244 Range Table

	Range	R6243	R6244
	320 mV	YES	YES
Voltage Source/	3.2 V	YES	YES
Voltage Limiter	20 V	No	YES
Voltage Limiter	32 V	YES	No
	110 V	YES	No
	32 μΑ	YES	No
	320 µA	YES	YES
	3.2 mA	YES	YES
Current Source/	32 mA	YES	YES
Current Limiter	320 mA	YES	YES
	2 A	YES	No
	3.2 A	No	YES
	10 A	No	YES

Voltage/Current Source

Total Accuracy of Reverse Polarity Limiter: Accuracies of source value and reverse polarity limiter are the values in the table below, plus the limiter total accuracy. (The table does not apply to the stability or temperature coefficient.)

	Range	Total Accuracy ±(% of setting + V)
	320 mV	0.25 + 8 mV
Reverse Polarity/	3.2 V	0.25 + 8 mV
Voltage Limiter	20 V/32 V	0.25 + 80 mV
	110 V	0.25 + 300 mV
	Range	Total Accuracy ±(% of setting + A)
	32 μΑ	0.25 + 650 nA
	320 µA	0.25 + 6.5 μA
	3.2 mA	0.25 + 65 μA
Reverse Polarity/	32 mA	0.25 + 650 μA
Current Limiter	320 mA	0.25 + 6.5 mA
	2 A/3.2 A	0.25 + 65 mA
	10 A	0.25 + 650 mA

Output Noise: Voltage source is no load and within maximum load [Vp-p].

Current source is at the following load resistance [Ap-p].

Voltage Source

Range	Load	Low Frequency Noise		High Frequency Noise
resistance		DC to 100 Hz	DC to 10 kHz	DC to 20 MHz
320 mV	_	60 μV	300 μV	5 mV
3.2 V	_	100 μV	400 μV	5 mV
20 V/32 V	_	1 mV	3 mV	6 mV
110 V	-	3 mV 5 mV		10 mV

Current Source

Range	Load	Low Frequency Noi <mark>se High Frequency Noise Noise High Frequency Noise Noi</mark>		
-	resistance	DC to 100 Hz	DC to 10 kHz	DC to 20 MHz
32 µA	10 kΩ	10 nA	60 nA	500 nA
320 µA	10 k Ω	30 nA	150 nA	600 nA
3.2 mA	1 kΩ	200 nA	2 μΑ	6 µA
32 mA	1 kΩ	2 μΑ	15 μA	20 μA
320 mA	1 kΩ	20 μA	100 μA	150 µA
2 A/3.2 A	100 Ω	200 μA	1 mA	1.5 mA
10 A	10 Ω	2 mA	10 mA	15 mA

Transient Noise at switchings:

		Typical values [p-p]	Load resistance
Output On/ Off Noise	Voltage Source Current Source	600 mV 600 mV	at 100 kΩ at 100 kΩ
Range Changing Transient Noise	Voltage Source Current Source Voltage Limiter Current Limiter Voltage Measurement Current Measurement	50 mV 70 digits + 50 mV 50 mV (*2) 50 mV (*1) (*2) 50 mV (*2)	- - - - -
Polarity Changing Transient Noise	Voltage Source Current Source	50 mV 50 mV/RL	- RL
Power Source Off Noise		600 mV	at 100 kΩ

^{(*1) 80} mV when the voltage source range is 110 V.

Settling Time:

The time to reach maximum value $\pm 0.03\%$ when output shifts from zero to Full Scale. However pure load resistance, load capacitance 2.5 pF or less, source value, and Limiter setting are at Full Scale.

	Range	Settling Time
	320 mV	200 1
Voltage Source	3.2 V	300 µs or less
	20 V/32 V	700 µs or less
	110 V	2 ms or less
200	32 μΑ	5 ms or less
ai So	320 μA	
of for all	3.2 mA	
Current Source	32 mA]
Current Source	320 mA	3 ms or less
Eci My	2 A/3.2 A	
OM.	10 A	

Line Regulation:

±0.003% of range

Load Regulation

Voltage $\bar{\text{Source:}} \pm 0.003\%$ of range or less For maximum load at 4 wire kelvin connection.

Current Source: By CMV (A x Vo/1 V) of the total accuracy.

Output Resistance: For 2 wire connection. However output cable is not included.

Maximum Load capacitance: Maximum load capacitance with no oscillation during voltage source or voltage Limiter operation.

Range	Outpu	Maximum Load	
nunge	Voltage Source	Current Source	Capacitance
32 μΑ	500 mΩ or less	1 x 10° Ω or more	1 μF
320 µA	100 mΩ or less	1 x 10° Ω or more	1 μF
3.2 mA	10 mΩ or less	1 x 10 ⁸ Ω or more	100 μF
32 mA	10 mΩ or less	1 x 10 ⁷ Ω or more	100 μF
320 mA	10 m Ω or less	1 x 10 ° Ω or more	2000 μF
2 A/3.2 A	10 mΩ or less	1 x 10 ⁵ Ω or more	2000 µF
10 A	10 m Ω or less	1 x 10 ⁴ Ω or more	2000 μF

Standard attached cable resistance: 100 m Ω or less

^(*2) Not during limiter operation. During limiter operation, this is the same as the source range switching noise.

RL: Resistance of Load value

Maximum Inductive load:

Maximum inductive load with no oscillation during current source or current limiter operation.

Current Source Range Current Limiter Range	32 μΑ	320 μΑ	3.2 mA to 10 A
Maximum Inductive load	100 µH	500 μH	1 mH

Voltage/Current Measurement

Effective CMRR: when using DC and AC 50/60 Hz $\pm 0.08\%$, and 1 $k\Omega$ unbalanced impedance

	Integration time	
	500 μs to 10 ms	1 PLC to 100 PLC
Voltage Measurement/ Current Measurement	60 dB	120 dB

NMRR: when AC 50/60 Hz ±0.08%

	Integration time		
	500 µs to 10 ms	1 PLC to 100 PLC	
Voltage Measurement/ Current Measurement	0 dB	60 dB	



Source/Measurement F	iunctions
DC Source/Measurement:	DC voltage, current source/measurement
	Pulse voltage, current source/measurement LO value of Pulse is the same polarity as the HI value.
DC Sweep Source/ Measurement:	Source/Measurement by Linear, Log, and Random
Pulse Sweep Source/ Measurement:	Source/Measurement by Linear, Log, and Random LO value of Pulse is the same polarity as the HI value.
Sweep mode:	Reverse ON (2 way)/OFF (1 way)
Sweep Repeat Times:	1 to 1000, Infinite
Number of Sweep Maximum Step:	5000 step
Random Sweep Maximum Memory:	5000 data
Measurement Data Buffer Memory:	5000 data
Calculation Functions:	NULL calculation Comparator calculation (HI/GO/LO)
Trigger Method:	Automatic Trigger (DC free run/Pulse repeat) Source/Measurement by external trigger
Output Terminal:	Front; Safety Socket HI OUTPUT, HI SENSE, LO OUTPUT, LO SENSE DRIVING GUARD (For R6243)
Maximum Input Voltage: R6243;	110 V peak MAX (Between HI-LO, DG-LO) 1 V peak MAX (Between OUTPUT-SENSE) (Between HI-DG) 500 V peak MAX (Between LO-FRAME) 20 V peak MAX (Between HI-LO) 2 V peak MAX (Between OUTPUT-SENSE) 250 V peak MAX (Between LO-FRAME)
Remote Sensing Voltage:	R6243;±0.5 V MAX R6244;±1 V MAX Between HI OUTPUT-HI SENSE, Between LO OUTPUT-LO SENSE (The voltage between HI SENSE and LO SENSE shall be within the maximum output voltage.)
Resistance:	1 G Ω or more
Voltage Measurement Input Leakage Current:	±2 nA or less
Maximum Guard Offset Voltage:	±2 mV; Between HI (SENSE) - DG (For R6243)
Maximum Allowable Guard Capacitance:	1000 pF; Between HI (OUTPUT or SENSE) - DG (For R6243)
Maximum Allowable Shield Capacitance:	5000 pF; Between DG-LO (OUTPUT or SENSE) (For R6243)
GPIB Interface:	In accordance with IEEE-std.488-1978 Interface Functions; SH1, AH1, T5, L4, SR1, RL1, PP0, DC1, DT1, C0, E2
Single-wire Signal:	•TRIGGER IN •SYNC OUT •COMPLETE OUT/BUSY IN/BUSY OUT •INTERLOCK/OPERATE IN/OPERATE OUT

Setting Time

Minimum Pulse Width: 1 ms

Minimum Step (Repaet) Time: when source range fixed, free run or

internal trigger mode, source delay time: 10 μs

Measurement	Memory Mode	Minimum Step Time
OFF	-	2 ms
	BURST	4 ms
ON*	NORMAL	40
	OFF	10 ms

^{*:} Measurement range fixed, integration time: 500 µs, measure delay time: 300 µs

Integration time: 500 $\mu s/1$ ms/10 ms/1 PLC/10 PLC/100 PLC Source Delay Time

Setting Range	Resolution	Setting Accuracy
10 μs to 600.00 ms	10 μs	
600.1 ms to 6000.0 ms	100 µs	±(0.1% + 30 μs)
6001 ms to 60000 ms	1 ms	1

Period (Pulse Interval)

Setting Range	Resolution	Setting Accuracy
2 ms to 600.00 ms	10 µs	
600.1 ms to 6000.0 ms	100 μs	±(0.1% + 30 μs)
6001 ms to 60000 ms	1 ms	

Pulse Width

Setting Range	Resolution	Setting Accuracy
1 ms to 600.00 ms	10 μs	±(0.1% + 30 μs)
600.1 ms to 6000.0 ms	100 μs	
6001 ms to 60000 ms	1 ms	

Measure Delay Time

<u> </u>		
Setting Range	Resolution	Setting Accuracy
300 μs to 600.00 ms	10 μs	
600.1 ms to 6000.0 ms	100 μs	±(0.1% + 30 μs)
6001 ms to 60000 ms	1 ms	

Resolution	Setting Accuracy		
1 ms	±(2% + 1 ms)		
ne	collin		
	- 21		
Resolution	Setting Accuracy		
	1 ms		

General Specifications

Operating environment: Ambient temparature; 0 to 50°C,

Relative humidity; 85% or less (no condensation) In the case of R6244, the ambient temparature is between 0 to 40°C at the following output range.

 $0 \text{ V} \le \text{Vo } \le 7 \text{ V}; \text{ Io } \ge 3/7 \text{ Vo } - 10 \text{ [A]}$

-7 V ≤ Vo ≤ 0 V; lo ≤ 3/7 Vo + 10 [A] -7 V ≤ Vo ≤ 0 V; lo ≤ 3/7 Vo + 10 [A] Vo; Output Voltage [V] lo; Output Currnet [A]

Storage environment: Ambient temparature; –25 to +70°C,

Relative humidity; 85% or less (no condensation)

Warmup: 60min. or more

(until the specified accuracy is reached)

Display: 5 x 7 dot matrix fluorescent character display

Power supply: AC100 V/120 V/220 V/240 V(switchable by user)

 Option No.
 Standard
 OPT. 32
 OPT. 42
 OPT. 44

 Power source voltage
 100 V
 120 V
 220 V
 240 V

A01402

A01044

A01023-100

A01038-100

Line frequency: 50 Hz/60 Hz Power comsumption: R6243; 340 V

R6243; 340 VA or less R6244; 400 VA or less

Dimensions: R6243; Approx. 212 (W) x 177 (H) x 450 (D) mm R6244; Approx. 212 (W) x 177 (H) x 500 (D) mm

Mass: 15 kg or less

Input/output cable (Red and black safety cable, 1 m)

Input/output cable (4-wire banana-Alligator clip, 1m) Input/output cable (4-wire banana-banana, 1m)

Standard accessories

Power cable

Test fixture	R12701A
Test lead (1m)	A01041
Input/output cable (Red and black safety cable, 1 m)	A01044
Alligator clip adaptor	A08532
Banana chip adaptor	A08531
Rack mounting set (EIA, Twin, with Front handle)	A02710
Rack mounting set (JIS, Twin, with Front handle)	A02711
Rack mounting set (EIA, Twin, without Front handle)	A02720
Rack mounting set (JIS, Twin, without Front handle)	A02721
Rack mounting set (EIA, Single)	A02469
Rack mounting set (JIS, Single)	A02269
Side joint kit (4U, Twin)	A02641
Sliding rail set	A02615

For R6243

For R6244				
Input/output cable (4-wire banana-banana, 0.5m)	A01047-01			
Input/output cable (4-wire banana-banana, 1m)	A01047-02			
Input/output cable (4-wire banana-banana, 1.5m)	A01047-03			
Input/output cable (4-wire banana-banana, 2m)	A01047-04			

Please be sure to read the product manual thoroughly before using the products. Specifications may change without notification.

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